

Notice of References Cited

Application/Control No.

10/782,573

Applicant(s)/Patent Under
Reexamination
EHRMAN ET AL.

Examiner

Christopher J. Clark

Art Unit

2112

Page 1 of 1

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-----------------------|----------------|
| * | A | US-4,703,409 | 10-1987 | Spreen, James H. | 363/45 |
| * | B | US-5,179,508 | 01-1993 | Lange et al. | 363/16 |
| * | C | US-4,517,633 | 05-1985 | Melcher, Domenic | 363/21.04 |
| * | D | US-4,441,146 | 04-1984 | Vinciarelli, Patrizio | 363/20 |
| * | E | US-5,959,849 | 09-1999 | Batarseh et al. | 363/16 |
| * | F | US-4,447,866 | 05-1984 | Reeves, Charles R. | 363/21.08 |
| * | G | US-2,358,520 | 09-1944 | LANDON VERNON D | 343/821 |
| * | H | US-3,766,504 | 10-1973 | Yannucci et al. | 336/70 |
| * | I | US-4,462,069 | 07-1984 | Becky, Raymond | 363/23 |
| * | J | US-4,821,163 | 04-1989 | Bloom, Gordon E. | 363/49 |
| * | K | US-5,428,523 | 06-1995 | McDonnial, John E. | 363/71 |
| * | L | US-4,389,124 | 06-1983 | Longenecker, Bruce A. | 374/147 |
| * | M | US-4,245,286 | 01-1981 | Paulkovich et al. | 363/21.11 |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | ADP3050: 200 kHz, 1 A High-Voltage Step-Down Switching Regulator. Analog Devices [online], December 2000 [retrieved on 2006-10-02]. Retrieved from the Internet: <URL: http://www.analog.com/UploadedFiles/Data_Sheets/ADP3050.pdf >. |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.